SN74SSTV32867 26-BIT REGISTERED BUFFER WITH SSTL 2 INPUTS AND LVCMOS OUTPUTS

SCES362B - OCTOBER 2001 - REVISED MAY 2002

- Member of the Texas Instruments
 Widebus+™ Family
- Output Edge-Control Circuitry Minimizes Switching Noise in an Unterminated DIMM Load
- Supports SSTL_2 Data Inputs
- Differential Clock (CLK and CLK) Inputs
- Supports LVCMOS Switching Levels on the RESET Input
- RESET Input Disables Differential Input Receivers, Resets All Registers, and Forces All Outputs Low
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)

description

This 26-bit registered buffer is designed for 2.3-V to 2.7-V V_{CC} operation.

All inputs are SSTL_2, except the LVCMOS reset (RESET) input. All outputs are edge-controlled LVCMOS circuits optimized for unterminated DIMM loads.

The SN74SSTV32867 operates from a differential clock (CLK and $\overline{\text{CLK}}$). Data are registered at the crossing of CLK going high and $\overline{\text{CLK}}$ going low.

The device supports low-power standby operation. When RESET is low, the differential input receivers are disabled, and undriven (floating) data, clock, and reference voltage (V_{REF}) inputs are allowed. In addition, when RESET is low, all registers are reset and all outputs are forced low. The LVCMOS RESET always must be held at a valid logic high or low level.

To ensure defined outputs from the register before a stable clock has been supplied, RESET must be held in the low state during power up.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

Widebus+ is a trademark of Texas Instruments.



GKE PACKAGE (TOP VIEW)

2 3 4 5 6 00000 В 00000 00000 С 00000 D 00000 Ε 00000 F 00000 G 00000 Н 00000 J 00000 Κ L 00000 00000 М 00000 Ν 00000 Р 00000 R 00000 Т

terminal assignments

	1	2	3	4	5	6
Α	D1	VCC	GND	V_{DDQ}	Q1	Q2
В	D3	D2	V _{REF}	GND	Q3	Q4
С	D5	D4	NC	GND	Q5	Q6
D	D7	D6	GND	V_{DDQ}	Q7	Q8
E	D9	D8	V _{CC}	GND	Q9	V_{DDQ}
F	D11	D10	GND	V_{DDQ}	Q10	GND
G	D13	D12	Vcc	V_{DDQ}	Q12	Q11
н	D15	D14	GND	GND	GND	Q13
J	CLK	NC	GND	GND	GND	Q14
ĸ	CLK	RESET	Vcc	V_{DDQ}	Q15	Q16
L	D16	D17	GND	V_{DDQ}	Q17	GND
М	D18	D19	V _{CC}	GND	Q18	V_{DDQ}
N	D20	D21	GND	V_{DDQ}	Q20	Q19
Р	D22	D23	NC	GND	Q22	Q21
R	D24	D25	NC	GND	Q24	Q23
Т	D26	VCC	GND	V_{DDQ}	Q26	Q25

ORDERING INFORMATION

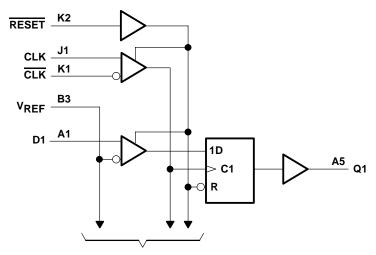
TA	PACK	AGE†	ORDERABLE PART NUMBER	TOP-SIDE MARKING
0°C to 70°C	LFBGA – GKE	Tape and reel	SN74SSTV32867GKER	SV867

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE

	INPUTS								
RESET	CLK	CLK	D	Q					
Н	1	\downarrow	Н	Н					
Н	\uparrow	\downarrow	L	L					
Н	L or H	L or H	Χ	Q_0					
L	X or floating	X or floating	X or floating	L					

logic diagram (positive logic)



To 25 Other Channels

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC} or V _{DDQ}	–0.5 V to 3.6 V
Input voltage range, V _I (see Note 1)	–0.5 V to V _{CC} + 0.5 V
Output voltage range, VO (see Notes 1 and 2)	$-0.5 \text{ V to V}_{DDQ} + 0.5 \text{ V}$
Input clamp current, I _{IK} (V _I < 0)	–50 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{DDQ})	±50 mA
Continuous output current, I _O (V _O = 0 to V _{DDQ})	±50 mA
Continuous current through each V _{CC} , V _{DDQ} , or GND	±100 mA
Package thermal impedance, θ _{JA} (see Note 3)	40°C/W
Storage temperature range, T _{stq}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
 - 2. This value is limited to 3.6 V maximum.
 - 3. The package thermal impedance is calculated in accordance with JESD 51-7.



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recommended operating conditions (see Note 4)

			MIN	NOM	MAX	UNIT
Vcc	Supply voltage		V_{DDQ}		2.7	V
V_{DDQ}	Output supply voltage		2.3		2.7	V
VREF	Reference voltage (V _{REF} = V _{DDQ} /2)		1.15	1.25	1.35	V
VTT	Termination voltage	V _{REF} -40mV	V _{REF}	V _{REF} +40mV	V	
٧ _I	Input voltage		0		VCC	V
VIH	AC high-level input voltage	Data input	V _{REF} +310mV			V
V _{IL}	AC low-level input voltage	Data input			V _{REF} -310mV	V
VIH	DC high-level input voltage	Data input	V _{REF} +150mV			V
V _{IL}	DC low-level input voltage	Data input			V _{REF} -150mV	V
VIH	High-level input voltage	RESET	1.7			V
V_{IL}	Low-level input voltage	RESET			0.7	V
VICR	Common-mode input voltage range	CLK, CLK	0.97		1.53	V
V _{I(PP)}	Peak-to-peak input voltage	CLK, CLK	360			mV
ЮН	High-level output current				-8	mA
loL	Low-level output current				8	mA
TA	Operating free-air temperature		0		70	°C

NOTE 4: The RESET input of the device must be held at V_{CC} or GND to ensure proper device operation. The differential inputs must not be floating unless RESET is low. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.



electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

P/	ARAMETER	TEST CONDIT	IONS	Vcc	MIN	TYP†	MAX	UNIT	
VIK		I _I = -18 mA		2.3 V			-1.2	V	
V0		I _{OH} = -100 μA	2.3 V to 2.7 V	V _{DDQ} -0.2			V		
VOH		I _{OH} = -8 mA		2.3 V	1.7			V	
VOL		I _{OL} = 100 μA		2.3 V to 2.7 V			0.2	V	
VOL		$I_{OL} = 8 \text{ mA}$		2.3 V			0.4	V	
IJ	All inputs	$V_I = V_{CC}$ or GND	_	2.7 V			±5	μA μA mA	
	Static standby	RESET = GND					40	μΑ	
ICC	Static operating	$\overline{RESET} = V_{CC},$ $V_I = V_{IH}(AC) \text{ or } V_{IL}(AC)$	IO = 0	2.7 V			95	mA	
	Dynamic operating – clock only	RESET = V _{CC} , V _I = V _{IH} (<u>AC</u>) or V _{IL} (AC), CLK and CLK switching 50% duty cycle				44		μΑ/ MHz	
ICCD	Dynamic operating – per each data input	RESET = V _{CC} , V _I = V _{IH} (<u>AC)</u> or V _{IL} (AC), CLK and CLK switching 50% duty cycle, One data input switching at one-half clock frequency, 50% duty cycle	IO = 0	2.5 V		5		μΑ/ clock MHz/ D input	
	Data inputs	$V_I = V_{REF} \pm 310 \text{ mV}$			2.5	3.5	4.5		
C _i ‡	CLK, CLK	V _{ICR} = 1.25 V,	2.5 V	4	4.5	5	pF		
	RESET	$V_I = V_{CC}$ or GND			3.9	5	5.5		

[†] All typical values are at V_{CC} = 2.5 V, T_A = 25°C.

timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

				V _{CC} =		UNIT	
				MIN	MAX		
fclock	Clock frequency				200	MHz	
t _W	Pulse duration	CLK, CLK high or low	2.5		ns		
tact	Differential inputs active time		22	ns			
tinact	Differential inputs inactive to	me (see Note 6)			22	ns	
	Setup time	Fast slew rate (see Notes 7 and 9)	D	0.75		ns	
tsu	Setup time	Slow slew rate (see Notes 8 and 9)	Data before CLK↑, CLK↓	0.9			
4.	I laid time	Fast slew rate (see Notes 7 and 9)	Data after CLK↑, CLK↓	0.75			
th	Hold time	Slow slew rate (see Notes 8 and 9)	Data after CLKT, CLK↓	0.9		ns	

NOTES: 5. Data inputs must be low a minimum time of tact min, after RESET is taken high.

- 6. Data and clock inputs must be held at valid levels (not floating) a minimum time of t_{inact} min, after RESET is taken low.
- 7. Data signal input slew rate ≥1 V/ns
- 8. Data signal input slew rate ≥0.5 V/ns and <1 V/ns
- 9. CLK, CLK input slew rates are ≥1 V/ns.



[‡] Measured with 50-MHz input frequency

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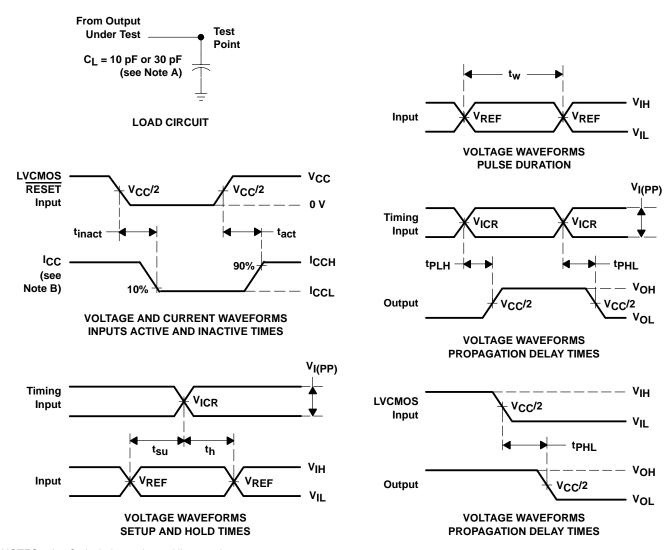
switching characteristics over recommended operating free-air temperature range, $V_{REF} = V_{DDQ}/2$ and $C_L = 10$ pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} =	UNIT	
	(1141 01)	(6611 61)	MIN	MAX	
fmax			200		MHz
^t pd	CLK and CLK	Q	1.1	2.8	ns
tPHL	RESET	Q		5	ns

switching characteristics over recommended operating free-air temperature range, $V_{REF} = V_{DDQ}/2$ and $C_L = 30$ pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} =	2.5 V 2 V	UNIT
	(INFOT)	(001F01)	MIN	MAX	
f _{max}			200		MHz
^t pd	CLK and CLK	Q	1.1	3.8	ns
^t PHL	RESET	Q		5	ns

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. ICC tested with clock and data inputs held at V_{CC} or GND, and I_{O} = 0 mA.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , input slew rate = 1 V/ns \pm 20% (unless otherwise noted).
- D. The outputs are measured one at a time with one transition per measurement.
- E. $V_{REF} = V_{DDQ}/2$
- F. $V_{IH} = V_{REF} + 310$ mV (ac voltage levels) for differential inputs. $V_{IH} = V_{CC}$ for LVCMOS input.
- G. $V_{IL} = V_{REF} 310 \text{ mV}$ (ac voltage levels) for differential inputs. $V_{IL} = GND$ for LVCMOS input.
- H. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms





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PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing		ckage Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
SN74SSTV32867GKER	ACTIVE	LFBGA	GKE	96 1	1000	TBD	SNPB	Level-3-220C-168 HR

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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OTHER QUALIFIED VERSIONS OF SN74SSTV32867:

Enhanced Product: SN74SSTV32867-EP

NOTE: Qualified Version Definitions:

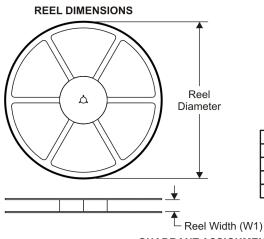
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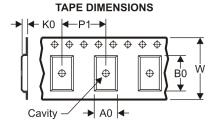




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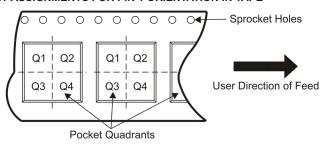
TAPE AND REEL INFORMATION





Α	0	Dimension designed to accommodate the component width
В	0	Dimension designed to accommodate the component length
		Dimension designed to accommodate the component thickness
٧	٧	Overall width of the carrier tape
ГР	1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

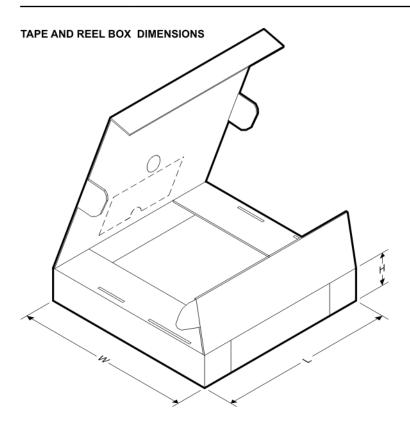


*All dimensions are nominal

Device	_	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74SSTV32867GKER	LFBGA	GKE	96	1000	330.0	24.4	5.7	13.7	2.0	8.0	24.0	Q1

PACKAGE MATERIALS INFORMATION

11-Mar-2008

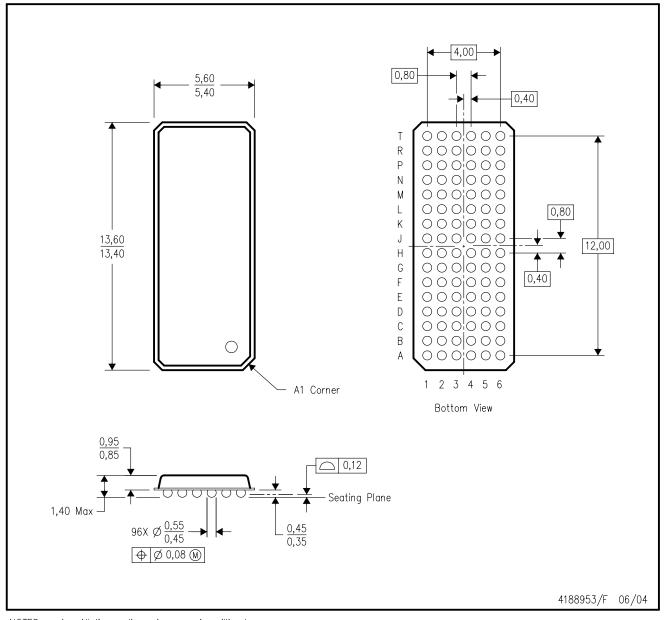


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74SSTV32867GKER	LFBGA	GKE	96	1000	346.0	346.0	41.0

GKE (R-PBGA-N96)

PLASTIC BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MO-205 variation CC.
- D. This package is tin-lead (SnPb). Refer to the 96 ZKE package (drawing 4204493) for lead-free.

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